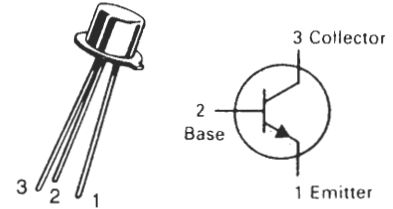


2N914

JAN, JTX AVAILABLE
CASE 22-03, STYLE 1
TO-18 (TO-206AA)



SWITCHING TRANSISTOR

NPN SILICON

Refer to 2N2368 for graphs.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	15	Vdc
Collector-Emitter Voltage ($R_{BE} \leq 10$ ohms)	V_{CER}	20	Vdc
Collector-Base Voltage	V_{CBO}	40	Vdc
Emitter-Base Voltage	V_{EBO}	5.0	Vdc
Collector Current — Continuous(1)	I_C	150	mAdc
Total Device Dissipation ($T_A = 25^\circ\text{C}$ Derate above 25°C)	P_D	360 2.06	mW mW/ $^\circ\text{C}$
Total Device Dissipation ($T_C = 25^\circ\text{C}$ Derate above 25°C)	P_D	1.2 6.8	Watts mW/ $^\circ\text{C}$
Total Device Dissipation ($T_C = 100^\circ\text{C}$ Derate above 100°C)	P_D	0.68	Watt
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to +200	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted.)

Characteristic	Symbol	Min	Max	Unit
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OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage(2) ($I_C = 30$ mAdc, $R_{BE} \leq 10$ ohms)	$V_{CER(sus)}$	20	—	Vdc
Collector-Emitter Sustaining Voltage(2) ($I_C = 30$ mAdc, $I_B = 0$)	$V_{CEO(sus)}$	15	—	Vdc
Collector-Base Breakdown Voltage ($I_C = 1.0$ μ Adc, $I_E = 0$)	$V_{(BR)CBO}$	40	—	Vdc
Emitter-Base Breakdown Voltage ($I_E = 10$ μ Adc, $I_C = 0$)	$V_{(BR)EBO}$	5.0	—	Vdc
Collector Cutoff Current ($V_{CE} = 20$ Vdc, $V_{BE} = 0.25$ Vdc, $T_A = 125^\circ\text{C}$)	I_{CEX}	—	10	μ Adc
Collector Cutoff Current ($V_{CB} = 20$ Vdc, $I_E = 0$) ($V_{CB} = 20$ Vdc, $I_E = 0$, $T_A = 150^\circ\text{C}$)	I_{CBO}	—	0.025 15	μ Adc
Emitter Cutoff Current ($V_{BE} = 4.0$ Vdc, $I_C = 0$)	I_{EBO}	—	0.1	μ Adc

ON CHARACTERISTICS

DC Current Gain(2) ($I_C = 10$ mAdc, $V_{CE} = 1.0$ Vdc) ($I_C = 10$ mAdc, $V_{CE} = 1.0$ Vdc, $T_A = -55^\circ\text{C}$) ($I_C = 500$ mAdc, $V_{CE} = 5.0$ Vdc)	h_{FE}	30 12 10	120 — —	—
Collector-Emitter Saturation Voltage(2) ($I_C = 200$ mAdc, $I_B = 20$ mAdc) ($I_C = 10$ mAdc, $I_B = 1.0$ thru 20 mAdc, $T_A = -55$ to $+125^\circ\text{C}$)	$V_{CE(sat)}$	— —	0.70 0.25	Vdc
Base-Emitter Saturation Voltage ($I_C = 10$ mAdc, $I_B = 1.0$ mAdc)	$V_{BE(sat)}$	0.70	0.80	Vdc

SMALL-SIGNAL CHARACTERISTICS

Current-Gain — Bandwidth Product ($I_C = 20$ mAdc, $V_{CE} = 10$ Vdc, $f = 100$ MHz)	f_T	300	—	MHz
Output Capacitance ($V_{CB} = 10$ Vdc, $I_E = 0$, $f = 1.0$ MHz)	C_{obo}	—	6.0	pF
Input Capacitance ($V_{BE} = 0.5$ Vdc, $I_C = 0$, $f = 1.0$ MHz)	C_{ibo}	—	9.0	pF

SWITCHING CHARACTERISTICS

Storage Time(3) ($I_C = I_{B1} = I_{B2} = 20$ mAdc)	t_s	—	20	ns
Turn-On Time(3) ($I_C = 200$ mAdc, $I_{B1} = 40$ mAdc, $I_{B2} = 20$ mAdc)	t_{on}	—	40	ns
Turn-Off Time(3) ($I_C = 200$ mAdc, $I_{B1} = 40$ mAdc, $I_{B2} = 20$ mAdc)	t_{off}	—	40	ns

(1) Limited by Power Dissipation.

(2) Pulse Test: Pulse Width = 300 μ s, Duty Cycle $\leq 1.0\%$.

(3) Measured on Sampling Scope: Pulse Width ≥ 200 ns.